

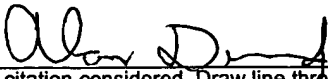
Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-023002	Application No. 08/907,182
	Applicant Yamazaki, et al.		
	Filing Date August 6, 1997	Group Art Unit 1753	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
ADD	AA	5,085,711	2/4/92	Iwamoto et al.	—	—	
ADD	AB	5,380,372	1/10/95	Campe et al.	—	—	
ADD	AC	5,426,061	6/20/95	Sopori	—	—	
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
ADD	AL	DE 3049226	3/1982	Pao Hsien Fang	—	—	X	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
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Examiner Signature 	Date Considered 8/27/01
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use separate sheet if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Pocket No. 2001 07977-023006	Application No. 08/907,182
	Applicant Yamazaki, et al.		APR 04 2001 TC 1700
	Filing Date August 6, 1997	Group Art Unit 1753	

U.S. Patent Documents


Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
ADD	AA	5,614,426	3/25/97	Funada et al.	438	150	
ADD	AB	5,696,388	12/9/97	Funada et al.	257	64	
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Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
ADD	AI	JP 47-024776	10/18/72	Japan	—	—	Full	
ADD	AJ	JP 49-134276	12/24/74	Japan	—	—		X
ADD	AK	JP 02-296377	12/6/90	Japan	—	—	Abstract Only	
ADD	AL	JP 03-218683	9/26/91	Japan	—	—	Abstract Only	
ADD	AM	JP 04-291967	10/16/92	Japan	—	—	Abstract Only	
ADD	AN	JP 04-360518	12/14/92	Japan	—	—	Abstract Only	
ADD	AO	JP 07-058338	3/3/95	Japan	—	—	Abstract Only	

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
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	AR	
	AS	

Examiner Signature 	Date Considered 6/27/01
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